



C8051F330D

25 MIPS, 8 kB Flash, 10-Bit ADC, 20-Pin Mixed-Signal MCU

Analog Peripherals

10-Bit ADC

- Programmable throughput up to 200 ksp/s
- Up to 16 external inputs; programmable as single-ended or differential
- Reference from internal V_{REF} , V_{DD} , or external pin
- Internal or external start of conversion sources
- Built-in temperature sensor ($\pm 3^\circ\text{C}$)

10-bit DAC (Current Mode)

Comparator

- Programmable hysteresis and response time
- Configurable to generate interrupts or reset
- Low current ($0.4\ \mu\text{A}$)

On-Chip Debug

- On-chip debug circuitry facilitates full speed, non-intrusive in-system debug (no emulator required)
- Provides breakpoints, single stepping, watchpoints
- Inspect/modify memory, registers, and stack
- Superior performance to emulation systems using ICE-chips, target pods, and sockets

Supply Voltage: 2.7 to 3.6 V

- Typical operating current: $6.4\ \text{mA}$ at 25 MHz
 $9\ \mu\text{A}$ at 32 kHz
- Typical stop mode current: $<0.1\ \mu\text{A}$

Temperature Range: -40 to $+85^\circ\text{C}$

High-Speed 8051 μC Core

- Pipelined instruction architecture; executes 70% of instructions in 1 or 2 system clocks
- Up to 25 MIPS throughput with 25 MHz clock
- Expanded interrupt handler

Memory

- 768 bytes data RAM
- 8 kB Flash; in-system programmable in 512 byte sectors (512 bytes are reserved)

Digital Peripherals

- 17 port I/O; all are 5 V tolerant
- Hardware SMBus™ (I2C™ compatible), SPI™, and UART serial ports available concurrently
- Programmable 16-bit counter/timer array with three capture/compare modules, WDT
- 4 general-purpose 16-bit counter/timers
- Real-time clock mode using PCA or timer and external clock source

Clock Sources

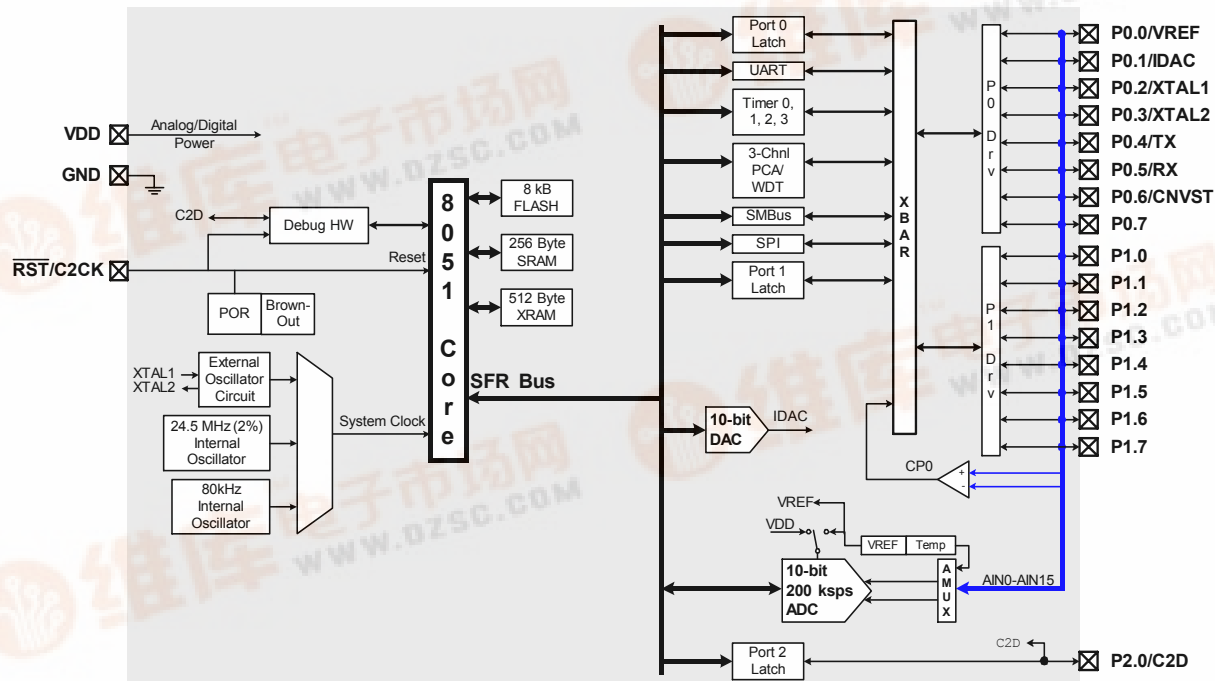
- Two internal oscillators:
 - 24.5 MHz, 2% accuracy supports UART operation
 - 80 kHz low frequency, low-power
- External oscillator: Crystal, RC, C, or Clock (1 or 2 pin modes)
- Can switch between clock sources on-the-fly

Package

- 20-pin DIP (lead-free package)

Ordering Part Numbers

- C8051F330D-GP



(T_A = -40 to +85 C°, VDD = 2.7 V unless otherwise specified)

Note 1: OSC1 can be calibrated in 2.5% steps using an internal calibration register.

C8051F330DK Development Kit

